Application/Control No. Applicant(s)/Patent Under Reexamination 09/925,331 VENKEN ET AL. **Notice of References Cited** Examiner Art Unit Page 1 of 1 2667 Kwang B. Yao **U.S. PATENT DOCUMENTS**

		Document Number	Date		· · · · · · · · · · · · · · · · · · ·
*		Country Code-Number-Kind Code	MM-YYYY	Name	Classification
*	Α	US-5,745,477	04-1998	Zheng et al.	370/230
*	В	US-6,094,418	07-2000	Soumiya et al.	370/231
*	С	US-6,452,905	09-2002	Smith et al.	370/236.1
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	'US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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